




<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/854,624	KOBAYASHI, YOKO	
	Examiner	Art Unit	
	Ryan F. Pitaro	2174	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
715	810				715	783	708	838	839	846	847
INTERNATIONAL CLASSIFICATION											
G	0	6	F	3/00							
				9/00							
				17/00							
				/							
				/							
Ryan F. Pitaro (Assistant Examiner) (Date)					 <b>KRISTINE KINCAID</b> SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date)					Total Claims Allowed: 17	
 (Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1	O.G. Print Fig. 15

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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